



PJM50H30NTH

N-Channel Power MOSFET

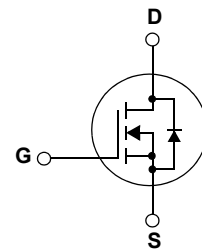
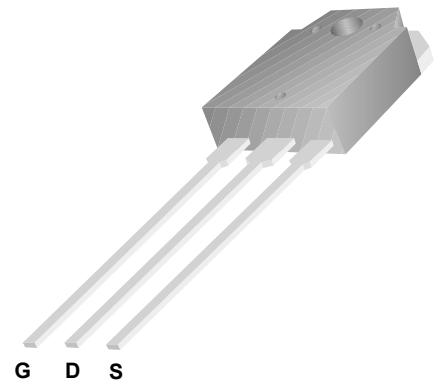
Features

- Advanced Planar Process
- $R_{DS(ON)}$, typ.=150m Ω @ V_{GS} =10V
- Low Gate Charge Minimize Switching Loss
- Rugged Poly Silicon Gate Structure

Applications

- BLDC Motor Driver
- Electric Welder
- High Efficiency SMPS

TO-3PN



Absolute Maximum Ratings

Ratings at $T_C = 25^\circ\text{C}$ unless otherwise specified.

Parameter		Symbol	Value	Units
Drain-to-Source Voltage		V _{DS}	500	V
Continuous Drain Current		I _D	30	A
	T _C =100 °C		18	
Pulsed Drain Current ^{Note 1}		I _{DM}	120	A
Gate-to-Source Voltage		V _{GS}	±30	V
Single Pulse Avalanche Energy		E _{AS}	2000	mJ
Peak Diode Recovery ^{Note 2}		dv/dt	5.0	V/ns
Power Dissipation		P _D	333	W
Derating Factor above 25°C			2. 63	W/°C
Operating Junction and Storage Temperature Range		T _{STG}	−55 to 150	°C
Maximum Temperature for Soldering		T _L	300	°C

Note: 1. Repetitive rating; pulse width limited by maximum junction temperature.

2. Package limited current.

3. Pulse width $\leq 380\mu\text{s}$; duty cycles $\leq 2\%$.



PJM50H30NTH

N-Channel Power MOSFET

Thermal Characteristics

Parameter	Symbol	Value	Units
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.38	$^{\circ}\text{C/W}$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	50	$^{\circ}\text{C/W}$

Electrical Characteristics

Ratings at $T_C = 25^{\circ}\text{C}$ unless otherwise specified.

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	500	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2.5	-	4.5	V
Gate Leakage Current	I _{GSS}	V _{DS} = 0V, V _{GS} = ±30V	-	-	±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =500V, V _{GS} = 0V	-	-	5	μA
		V _{DS} =400V, V _{GS} = 0V, T _J = 125°C	-	-	100	
Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 15A	-	0.15	0.2	Ω
Forward Transconductance	g _{FS}	V _{DS} =25V, I _D =15A	-	38	-	S
Dynamic Characteristics						
Total Gate Charge	Q _g	V _{DS} = 250V, V _{GS} =0 ~ 10V, I _D = 30A	-	108	-	nC
Gate-Source Charge	Q _{gs}		-	21	-	
Gate-Drain Charge	Q _{gd}		-	44	-	
Input Capacitance	C _{iss}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz	-	4150	-	pF
Output Capacitance	C _{oss}		-	82	-	
Reverse Transfer Capacitance	C _{rss}		-	500	-	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 250V, R _g = 10Ω, V _{GS} = 10V, I _D = 30A	-	34	-	ns
Turn-On Rise Time	t _r		-	114	-	
Turn-Off Delay Time	t _{d(off)}		-	108	-	
Turn-Off Fall Time	t _f		-	72	-	
Source-Drain Diode Characteristics						
Diode Forward Current	I _{SD}		-	-	30	A
Diode Forward Voltage	V _{SD}	I _S = 30 A, V _{GS} = 0V	-	0.88	1.5	V
Reverse Recovery Time	trr	I _S =30A, dI _F /dt=100A/μs, V _{GS} =0V	-	900	-	ns
Reverse Recovery Charge	Q _{rr}		-	2.1	-	μC



Electrical Characteristics Curves

Figure 1. Maximum Transient Thermal Impedance

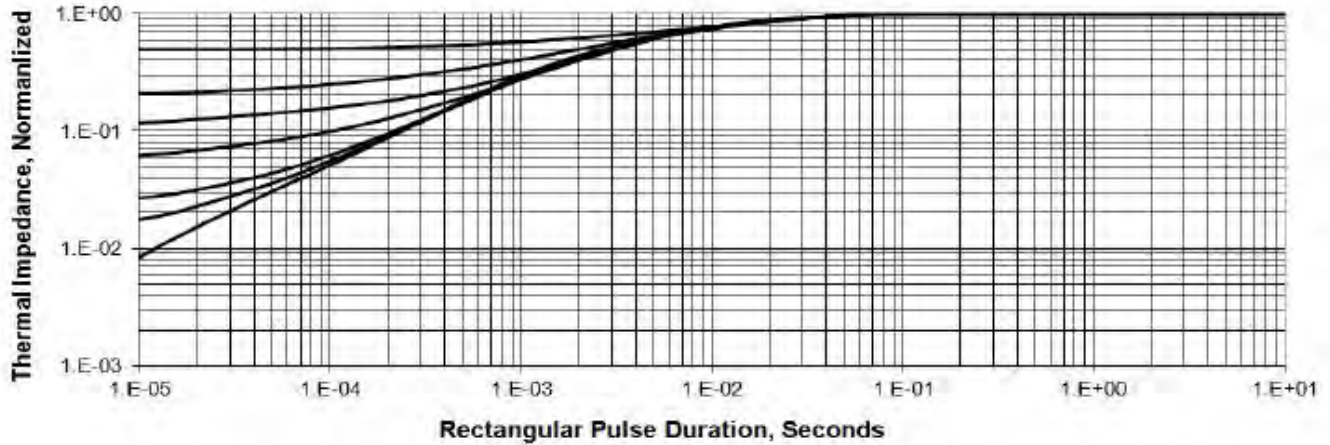


Figure 2 . Max. Power Dissipation vs Case Temperature

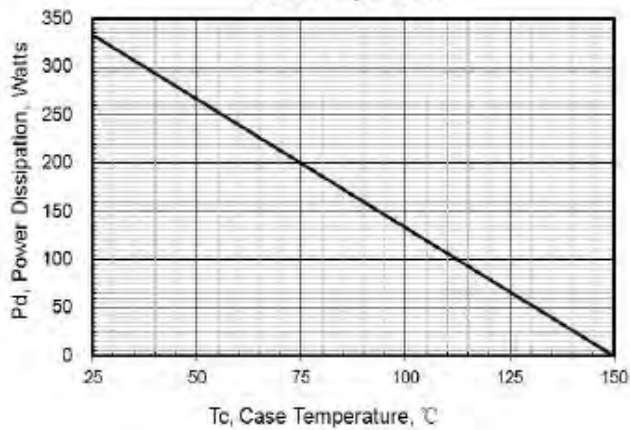


Figure 3 .Maximum Continuous Drain Current vs Tc

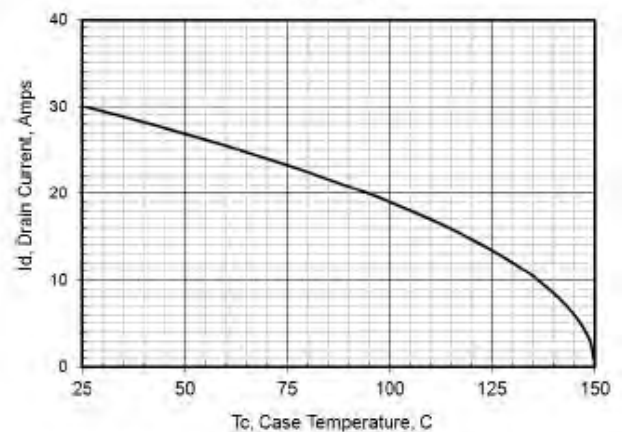


Figure 4. Output Characteristics

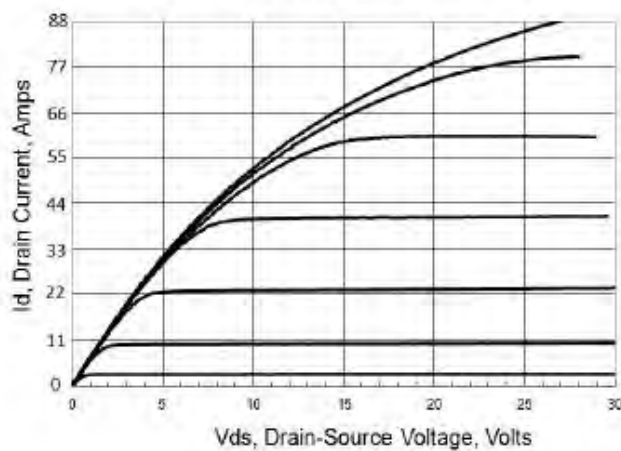
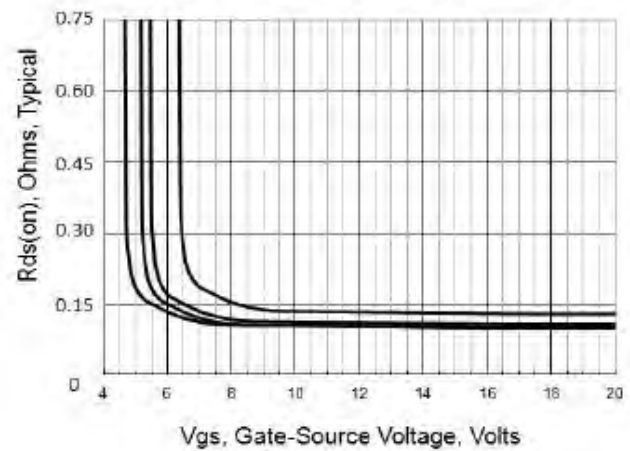


Figure 5. Rdson vs Gate Voltage





PJM50H30NTH

N-Channel Power MOSFET

Figure 6. Peak Current Capability

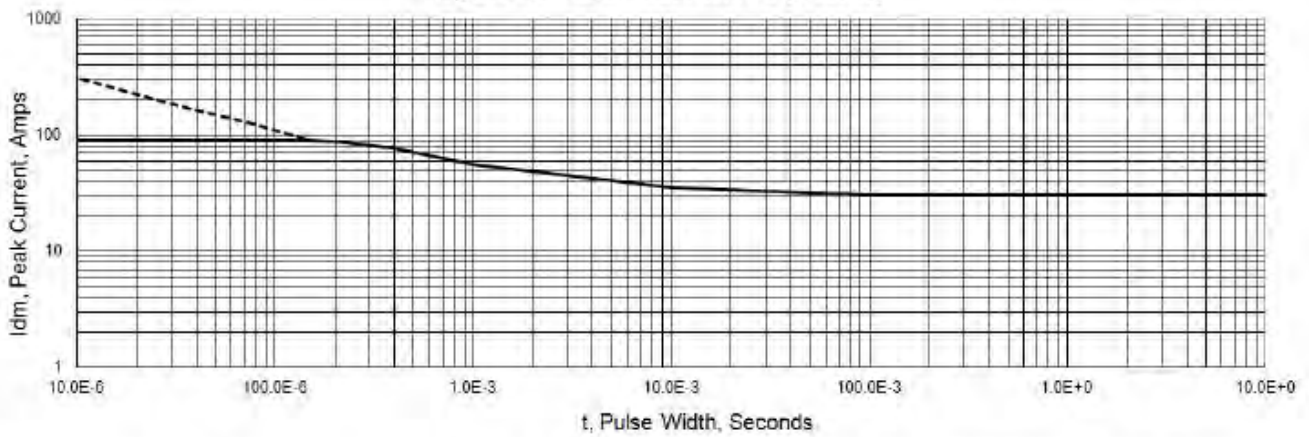


Figure 7. Transfer Characteristics

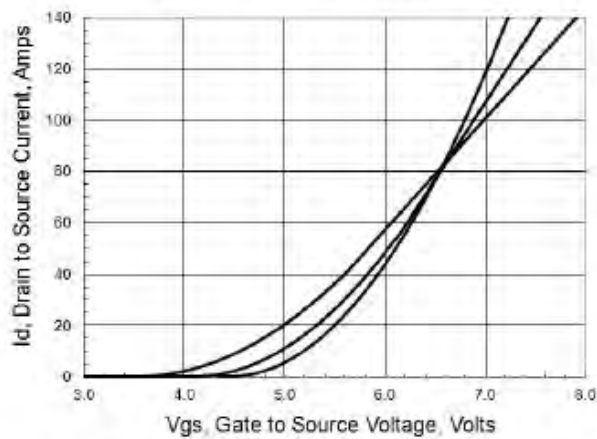


Figure 8. Unclamped Inductive Switching Capability

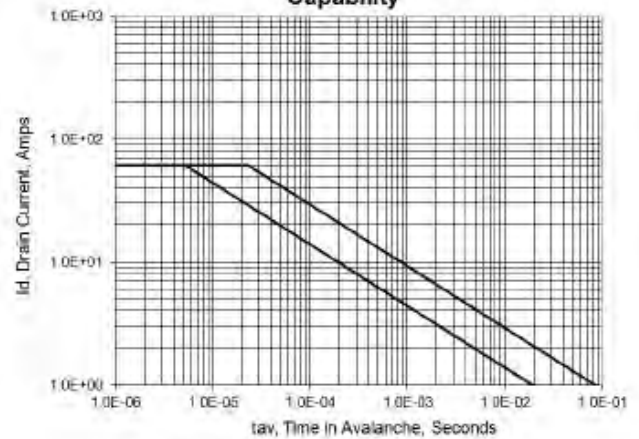


Figure 9. Drain to Source ON Resistance vs Drain Current

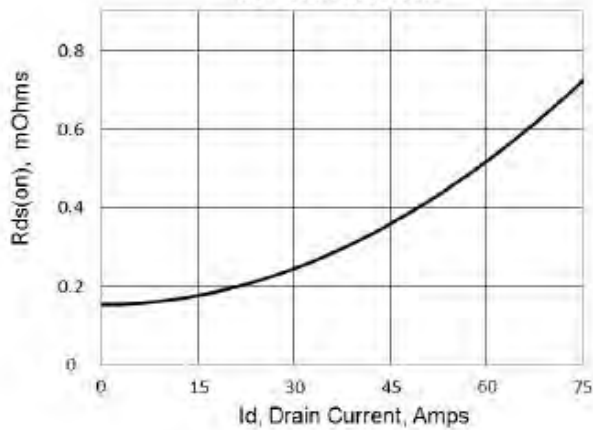
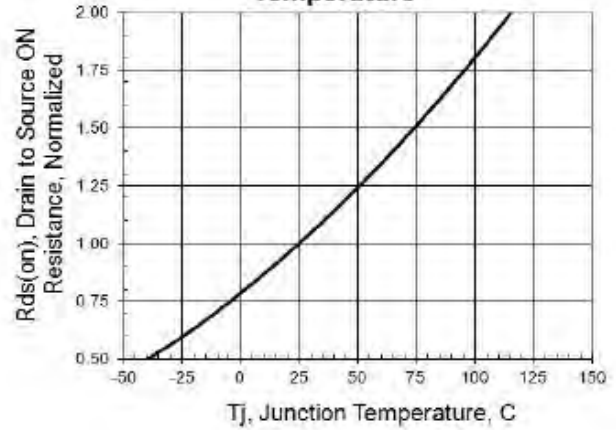


Figure 10. $R_{ds(on)}$ vs Junction Temperature





PJM50H30NTH

N-Channel Power MOSFET

Figure 11. Typical Breakdown Voltage vs. Junction Temperature

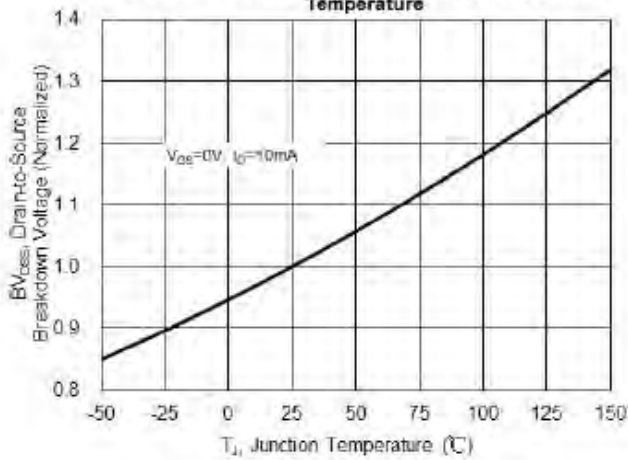


Figure 12. Typical Threshold Voltage vs. Junction Temperature

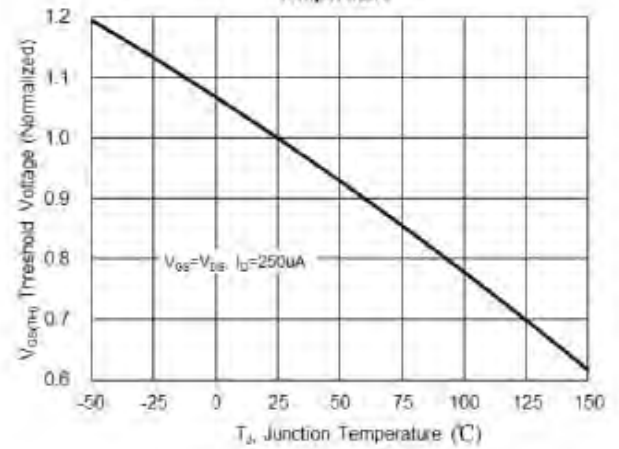


Figure 13 . Maximum Safe Operating Area

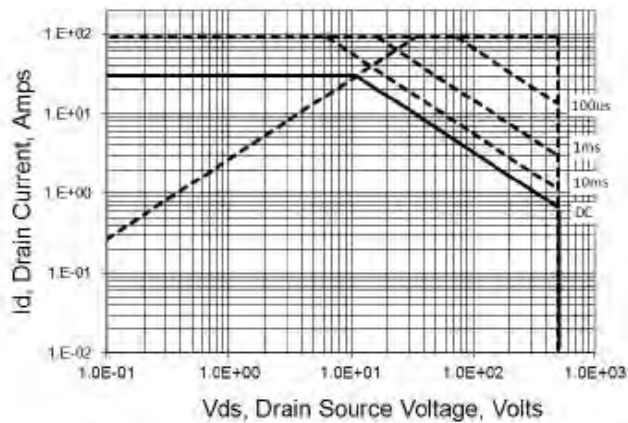


Figure 14. Capacitance vs Vds

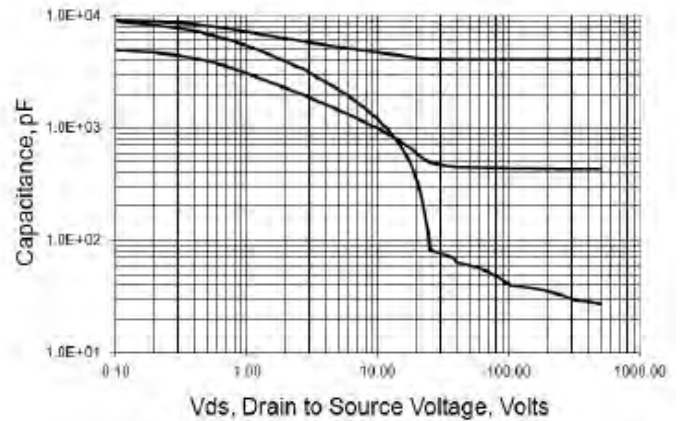


Figure 15 .Typical Gate Charge

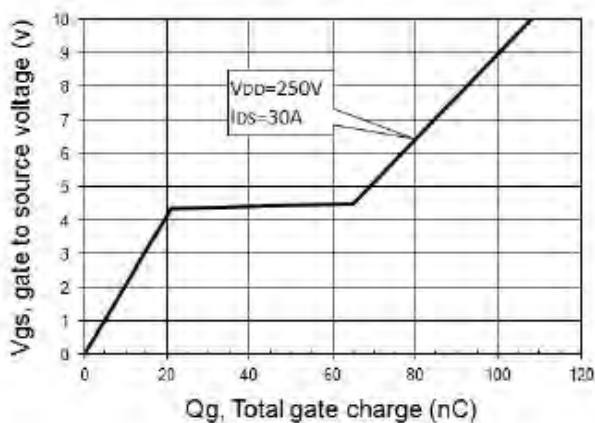
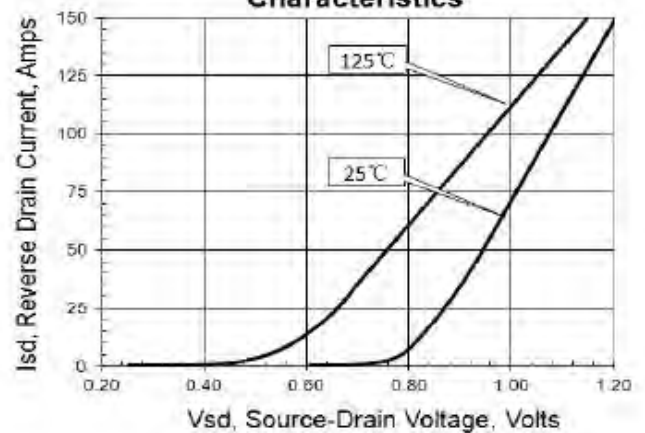


Figure 16. Body Diode Transfer Characteristics





TO-3PN



www.pingjingsemi.com
Revision: 1.0 Dec-2017